

Notice of References Cited

Application/Control No.

10/051/201

Applicant(s)/Patent Under
Reexamination
FONKWE ET AL

Examiner

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Art Unit

1623

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,607,748	08-2003	Lenaerts et al.	424/464
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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